





Features

- HIGH SPEED: 40 MBd TYPICAL DATA RATE
- HIGH COMMON MODE REJECTION
- HCPL-2400 = 50 V_{CM}
- HCPL-2411 = 300 V_{CM}
- AC PERFORMANCE GUARANTEED OVER TEMPERATURE
- COMPATIBLE WITH TTL, STTL, LSTTL, AND HCMOS LOGIC FAMILIES
- NEW, HIGH SPEED AIGaAs EMITTER
- THREE STATE OUTPUT (NO PULL-UP RESISTOR REQUIRED)
- HIGH POWER SUPPLY NOISE IMMUNITY
- RECOGNIZED UNDER THE COMPONENT PROGRAM OF U.L. (FILE NO. E55361) FOR DIELECTRIC WITHSTAND PROOF TEST VOLTAGES OF 1440 Vac, 1 MINUTE AND 2500 Vac, 1 MINUTE (OPTION 010).
- HCPL-5400/1 COMPATIBILITY

Applications

- ISOLATION OF HIGH SPEED LOGIC SYSTEMS
- COMPUTER-PERIPHERAL INTERFACES
- ISOLATED BUS DRIVER (NETWORKING APPLICATIONS)
- SWITCHING POWER SUPPLIES
- GROUND LOOP ELIMINATION
- HIGH SPEED DISK DRIVE I/O
- DIGITAL ISOLATION FOR A/D, D/A CONVERSION
- PULSE TRANSFORMER REPLACEMENT



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Description

The HCPL-2400/11 high speed optocouplers combine an 820 nm AlGaAs photon emitting diode with a high speed photon detector. This combination results in very high data rate capability and low input current. The three state output eliminates the need for a pull-up resistor and allows for direct drive of data buses. The hysteresis provides typically 0.25 mA of differential mode noise immunity and minimizes the potential for output signal chatter. Improved power supply rejection minimizes the need for special power supply bypassing precautions.

The electrical and switching characteristics of the HCPL-2400/11 are guaranteed over the temperature range of 0° C to 70° C.

The HCPL-2400/11 are compatible with TTL, STTL, LSTTL and HCMOS logic families. When Schottky type TTL devices (STTL) are used, a data rate performance of 20 MBd over temperature is guaranteed when using the application circuit of Figure 13. Typical data rates are 40 MBd.

Recommended Operating Conditions

Parameter	Symbol	Mín.	Max.	Units
Power Supply Voltage	Vcc	4.75	5.25	Volts
Input Current (High)	IF (ON)	-4	8	mA
Input Voltage (Low)	VF (OFF)		0.8	Volts
Enable Voltage (Low)	VEL	0	0.8	Volts
Enable Voltage (High)	VEH	2.0	Vcc	Volts
Operating Temperature	TA	0	70°	°C
Fan Out	N		5	TTL Loads

Absolute Maximum Ratings (No derating required up to 85° C)

Parameter	Symbol	Min.	Max.	Units	Note
Storage Temperature	Ts	-55	125	°C	
Operating Temperature	TA	0	85	°C	+
Lead Solder Temperature	260° C	for 10 s. (1.6 m	m below seating	and the second of a second second second	+
Average Forward Input Current	lF		10.0	mA	
Peak Forward Input Current	İFPK		20.0	mA	9
Reverse Input Voltage	VR		3.0	v	
Supply Voltage	Vcc	- 0	7.0	v	
Three State Enable Voltage	VE	-0.5	10.0	v	
Average Output Collector Current	lo	-25.0	25.0	mA	
Output Collector Voltage	Vo	-0.5	10.0	V	
Output Collector Power Dissipation	Po		40.0	mW	<u> </u>

Electrical Characteristics

For 0° C \leq T_A \leq 70° C, 4.75 V \leq V_{CC} \leq 5.25 V, 4 mA \leq I_{F(ON)} \leq 8 mA, 2.0 V \leq V_{EH} \leq 5.25, 0 V \leq V_{EL} \leq 0.8 V, 0 V \leq V_{F(OFF)} \leq 0.8 V except where noted. All Typicals at T_A = 25° C, V_{CC} = 5 V, I_{F(ON)} \approx 5.0 mA, V_{F(OFF)} = 0 V except where noted.

Parameter	Symbol	Min.	Тур.	Max.	Units	Test Conditions		Figure	Mate
Logic Low Output Voltage	VOL			0.5	Volts			Figure	Note
Logic High Output Voltage	Voн	2.4			Volts	$l_{OH} = -4.0 \text{ mA}$	- 200057	2	
Output Leakage Current	Іонн			100	μA	$V_0 = 5.25 V$	VF=0.8 V		
Logic High Enable Voltage	VEH	2.0			Volts		<u> </u>		
Logic Low Enable Voltage	VEL			8.0	Voits				
Logic High Enable Current	ІЕН			20	μA	VE = 2.4 V			
				100	μA	VE=5.25 V		-	
Logic Low Enable Current	IEL		-0.28	-0,4	mA	$V_E = 0.4V$			
Logic Low Supply Current	ICCL		19	26	mA	V _{CC} = 5.25 V			
Logic High Supply Current	Іссн		17	26	mA		and the second second		
High Impedance State	Iccz		22	28	mA	Vcc = 5.25 V			
Supply Current						VE = 5.25 V			
High Impedance State Output Current	lozi.			20	μA	Vo=0.4V	VE = 2 V		
Output Corrent	lozh			20	μA	Vo=2.4 V	VE = 2 V		
	lozh			100	μA	Vo = 5.25 V			
Logic Low Short Circuit Output Current	losl		52		mA	Vo = Vcc = 5.25 V	IF = 8 mA		1
Logic High Short Circuit Output Current	Іозн		-45		mА	V _{CC} = 5.25 V	lr=0 mA,		1.
Input Current Hysteresis	IHYS		0.25				Vo = GND		
Input Forward Voltage	VF	1.1	1.3	1.5	mA	V _{CC} = 5 V		3	
Input Reverse Breakdown	VB	3.0	5.0	+.5	Volts	$I_F = 5 \text{ mA}, T_A = 25^{\circ} C$		4	
Voltage	•1	0.0	5.0		Volts	$I_{\rm R} = 10 \ \mu {\rm A}, \ {\rm T}_{\rm A} = 25^{\circ}$	С		
Input Diode Temperature	٩٧٤		-1.44		mV/°C	IF = 5 mA			
Coefficient								4	
Input-Output Insulation	1-0								
				1	μA	45% RH, t = 5s, $V_{I-O} = 3kVdc, T_A = 25^{\circ}C$			2,8
Option 010	VISO	2500			VRMS	$RH \le 50\%$, t = 1 min.			10
Input-Output Resistance	RI-0		1012		ohms	VI-0 = 500 VDC			2
Input-Output Capacitance	Ci-a		0.6		pF	$f = 1 MHz$, $V_{I-O} = 0 V dc$			2 .
Input Capacitance	Cin		20		pF	$f = 1 MHz, V_F = 0V, P$		-	

Switching Characteristics

 $_{0^{\circ}C} \le T_{A} \le 70^{\circ}$ C, 4.75 V \le V_{CC} ≤ 5.25 V, 0.0 V \le V_{EN} ≤ 0.8 V. 4 mA \le I_F ≤ 8.0 mA. All Typicals V_{CC} = 5 V, T_A $= 25^{\circ}$ C, I_F = 5.0 mA except where noted.

Parameter	Symbol		Min.	Typ.	Max.	Units	Test Conditions		Figure	Note
Propagation Delay Time to	t _{PHL}				55	ns	$I_{F(ON)} = 7.0 \text{ mA}$		5, 6, 7	4
Logic Low Output Level			15	33	60	ns			5, 6, 7	3
Propagation Delay Time to	^t PLH				55	ns	$I_{F(ON)} = 7.0 \text{ mA}$		5, 6, 7	4
Logic High Output Level			15	30	60	ns			5, 6, 7	З
Pulse Width Distortion	Itent-teth]			2	15	ns	I _{F(ON)} = 7.0 mA		5, 8	4
				3	25	ns			5, 8	
Channel Distortion	ΔtpHL			8	25	ns			5	5
	ΔtpLH			8	25	ns			5	5
Output Rise Time	tr			20		ns			5	
Output Fall Time	tę			10		ns			5	
Output Enable Time to Logic High	[†] PZH			15		ns			9, 10	
Output Enable Time to Logic Low	t _{PZL}			30		ns			9, 10	
Output Disable Time from Logic High	t _{PHZ}			20		пs			9, 10	
Output Disable Time from Logic Low	t _{PLZ}			15		ns			9, 10	
Logic High Common Mode Transient Immunity	[CM _H]	2400	1000	10,000		V/µs	$V_{CM} = 50 V$	$T_A = 25^{\circ}C, I_F = 0$	11, 12	6
		2411	1000			V/µs	V _{CM} = 300 V		11, 12	0
Logic Low Common Mode Transient Immunity	[CML]	2400	1000	10,000		V/µs	V _{CM} = 50 V	T _A =25°C, I _F =4mA	11, 12	6
		2411	1000			V/µs	V _{CM} = 300 V		11, 12	
Power Supply Noise Immunity	PSNI			0.5		V _{p-p}	$V_{CC} = 5.0 \text{ V}, 48 \text{ Hz} \le F_{AC} \le 50 \text{ MHz}$			7

Notes:

- 1. Duration of output short circuit time not to exceed 10 ms.
- 2. Device considered a two terminal device: pins 1-4 shorted together, and pins 5-8 shorted together.
- 3. tPHL propagation delay is measured from the 50% level on the rising edge of the input current pulse to the 1.5 V level on the falling edge of the output pulse. The tPLH propagation delay is measured from the 50% level on the falling edge of the input current pulse to the 1.5 V level on the rising edge of the output pulse.
- 4. This specification simulates the worst case operating conditions of the HCPL-2400/11 over the recommended operating temperature and V_{CC} range with the suggested applications circuit of Figure 13.
- Channel distortion describes the worst case variation of propagation delay from one part to another at identical operating conditions.
- 6. CM_H is the maximum slew rate of common mode voltage that can be sustained with the output voltage in the logic high state (V_{O(MIN)} > 2.0 V). CM_L is the maximum slew rate of common mode voltage that can be sustained with the output voltage in the logic low state (V_{O(MAX)} < 0.8 V).</p>
- 7. Power Supply Noise Immunity is the peak to peak amplitude of the ac ripple voltage on the Vcc line that the device will withstand and still remain in the desired logic state. For desired logic high state, V_{OH(MIN)} > 2.0 V, and for desired logic low state, V_{OL(MAX)} < 0.8 volts.
- 8. This is a proof test. This rating is equally validated by a 2500 V ac, 1 second test per UL E55 361.
- 9. Peak Forward Input Current pulse width < 50 μs at 1 KHz maximum repetition rate.
- 10. See Option 010 data sheet for more information.



Figure 1. Typical Logic Low Output Voltage vs. Logic Low Output Current



Figure 2. Typical Logic High Output Voltage vs. Logic High Output Current



Figure 3. Typical Output Voltage vs. Input Forward Current



Figure 4. Typical Diode Input Forward **Current Characteristic**









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tf

Figure 6. Typical Propagation Delay vs. Ambient Temperature

INPUT VE MONITORING NODE

INPUT VE

OUTPUT VO

OUTPUT VO



5.0 V









Figure 10. Typical Enable Propagatio Delay vs. Ambient Temperature

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•MUST BE LOCATED < 1 cm FROM DEVICE UNDER TEST. ••SEE NOTE 6. • CL IS APPROXIMATELY 15 pF, WHICH INCLUDES PROBE AND STRAY WIRING CAPACITANCE.





Figure 12. Typical Common Mode Transient Immunity vs. Common Mode Transient Voltage

Applications



Figure 13. Recommended 20 MBd HCPL-2400/11 Interface Circuit



Figure 14. Alternative HCPL-2400/11 Interface Circuit







OPTOCOUPLERS

Data Rate, Pulse-Width Distortion, and Channel Distortion Definitions

In the world of data communications, a bit is defined as the smallest unit of information a computer operates with. A bit is either a Logic 1 or Logic 0, and is interpreted by a number of coding schemes. For example, a bit can be represented by one symbol through the use of NRZ code, or can contain two symbols in codes such as Biphase or Manchester (see Figure 16). The bit rate capability of a system is expressed in terms of bits/second (b/s) and the symbol rate is expressed in terms of Baud (symbols/second). For NRZ code, the bit rate capability equals the Baud capability because the code contains one symbol per bit of information. For Biphase and Manchester codes, the bit rate capability is equal to one half of the Baud capability, because there are two symbols per bit.

Propagation delay is a figure of merit which describes the finite amount of time required for a system to translate information from input to output when shifting logic levels. Propagation delay from low to high (t_{PLH}) specifies the amount of time required for a system's output to change from a Logic 0 to a Logic 1, when given a stimulus at the input. Propagation delay from high to low (t_{PHL}) specifies the amount of time required for a system's output to change from a Logic 1 to a Logic 0, when given a stimulus at the input (see Figure 5).

When tPLH and tPHL differ in value, pulse width distortion results. Pulse width distortion is defined as $|t_{PHL}-t_{PLH}|$ and determines the maximum data rate capability of a distortion-limited system. Maximum pulse width distortion on the order of 20–30% is typically used when specifying the maximum data rate capabilities of systems. The exact figure depends on the particular application (RS-232, PCM, T-1, etc.).

Channel distortion, (Δ tPHL, Δ tPLH), describes the worst case variation of propagation delay from device to device at identical operating conditions. Propagation delays tend to shift as operating conditions change, and channel distortion specifies the uniformity of that shift. Specifying a maximum value for channel distortion is helpful in parallel data transmission applications where the synchronization of signals on the parallel lines is important.

The HCPL-2400/11 optocouplers offer the advantages of specified propagation delay (tpLH, tpHL), pulse-width distortion (|tpLH-tpHL|), and channel distortion ($\Delta tpLH$, $\Delta tpHL$) over temperature, input forward current, and power supply voltage ranges.

Applications Circuits

A recommended application circuit for high speed operation is shown in Figure 13. Due to the fast current switching capabilities of Schottky family TTL logic (74STTL), data rates of 20 MBd are achievable from 0 to 70°C. the 74S04 totem-pole driver sources current to series-drive the input of the HCPL-2400/11 optocoupler. The 348 Ω resistor limits the LED forward current. The 30 pF speed-up capacitor assists in the turn-on and turn-off of the LED, increasing the data rate capability of the circuit. On the output side, the following logic can be directly driven by the output of the HCPL-2400/11 since a pull-up resistor is not required. If desired, a non-inverting buffer may be substituted on either the input or the output side to change the circuit function from Y = A to Y = A. This circuit satisfies all recommended operating conditions.

An alternative circuit is shown in Figure 14, which utilizes a 74S05 open-collector inverter to shunt-drive the HCPL-2400/11 optocoupler. This circuit also satisfies all recommended operating conditions.

The HCPL-2400/11 optocouplers are compatible with other logic familes, such as TTL, LSTTL, and HCMOS. However, the output drive capabilities of Schottky family devices greatly exceed those associated with TTL, LSTTL, and HCMOS logic families, and are recommended in high data rate (20 MBd) applications where fast drive current transitions are required to operate the HCPL-2400/11 with minimum pulse-width distortion.



Figure 17. Typical HCPL-2400/11 Output Schematic